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NEW QUESTION: 1 Which two statements are true about index full scans? **A.** An index fast full scan reads the whole index from the lowest value to the higher value. **B.** An index fast full scan reads the index block by block. **C.** Index nodes are not retrieved in the index order, and therefore the nodes are not in sequence. **D.** An index fast full scan multi block I/O to read the index structure in its entirety. **Answer: C, D** Explanation: **A:** To speed table and index block access, Oracle uses the `db_file_multiblock_read_count` parameter (which defaults to 8) to aid in getting full-table scan and full-index scan data blocks into the data buffer cache as fast as possible. **B:** The index nodes are not retrieved in index order, the rows will not be sequenced. Note: there are some requirements for Oracle to invoke the fast full-index scan. - All of the columns required must be specified in the index. That is, all columns in the select and where clauses must exist in the index. - The query returns more than 10 percent of the rows within the index. This 10 percent figure depends on the degree of multi-block reads and the degree of parallelism. - You are counting the number of rows in a table that meet a specific criterion. The fast full-index scan is almost always used for `count(*)` operations. Reference: index fast full scan tips An application supplied by a new vendor is being deployed and the SQL statements have plan baselines provided by the supplier. The plans have been loaded from a SQL tuning set. You require the optimizer to use these baselines, but allow better plans to be used, should any be created.

NEW QUESTION: 2 A customer is configuring an upstream disjoint Layer 2 network in a Cisco UCS domain. So far they have configured the following: Fabric Interconnects are in switching mode. There is symmetrical configuration for high availability. There are no overlapping VLANs. Each vNIC is communicating with one disjoint Layer 2 network. After validating the above, the customer is still having issues with network connectivity. What is the issue? **A.** Asymmetrical configuration for high availability needs to be configured. **B.** The fabric interconnect must be in end-host mode for a disjoint Layer 2 network. **C.** Overlapping VLANs are allowed in a disjoint Layer 2 network. **D.** The vNIC configuration is incorrect and must communicate with two or more disjoint layer 2 networks. **Answer: B**

NEW QUESTION: 3 What happens when you start the SAP HANA database? There are 2 correct answers to this question. Response: **A.** For the COLUMN tables, the primary indexes are created during load. **B.** The ROW store is completely loaded into the memory. **C.** The COLUMN store is completely loaded into the memory. **D.** For the ROW tables, the secondary indexes are created during load. **Answer: B, D**

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